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Form PTO 1449 (Modified)			OF COMMERCE EMARK OFFICE	217374US2PCT	New US PCT application based on PCT/JP00/03076					
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT						
LISTOF	KEFE	KENCES CITED BY AFF	PLICANT	Atsushi ITO, et al.						
				FILING DATE				GROUP		
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U.S. PATENT DOCUMENTS										
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS				
	AA	6 320 561	11/20/01	Hironobu ARIMOTO						
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		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO				
KN	AK	991052	04/05/00	EUROPE						
kN.	AL	991051	04/05/00	EUROPE						
kN	AM	908919	04/14/99	EUROPE		7				
KN	AN	997923	05/03/00	EUROPE						
KN	AO	4-291391	10/15/92	JAPAN						
KN	AP	4-322297	11/12/92	JAPAN						
KN	AQ	10-143108	05/29/98	JAPAN (with English abstract)				Х		
KN	AR	10-143106	05/29/98	JAPAN (with English abstract)				х		
KN	AS	8-278766	10/22/96	JAPAN (with English abstract)				х		
KN_	АТ	7-140927	06/02/95	JAPAN (with English abstract)				X		
KN,	AU	9-325736	12/16/97	JAPAN (with English abstract)				Х		
kN	AV	8-212930	08/20/96	JAPAN (with English abstract)				X		
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)										
	AW									
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